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Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D $T_A = +25^\circ C$
-20V	5.5Ω @ $V_{GS} = -4.5V$	-200mA
	7.5Ω @ $V_{GS} = -2.5V$	-170mA

Description

This new generation MOSFET has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions

Features

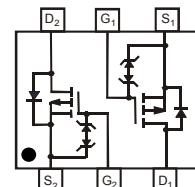
- Dual P-Channel MOSFET
- Low On-Resistance
 - 5.5Ω @ -4.5V
 - 7.5Ω @ -2.5V
 - 11.5Ω @ -1.8V
 - 17.5Ω @ -1.5V
- Very Low Gate Threshold Voltage $V_{GS(TH)} < 1.15V$
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT963
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish - Matte Tin annealed over Copper lead frame. Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 0.0027 grams (approximate)



Top View



Internal Schematic

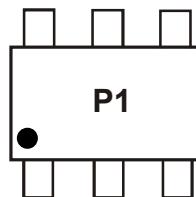
Ordering Information (Note 4)

Part Number	Case	Packaging
DMP210DUDJ-7	SOT963	10,000/Tape & Reel

Notes:

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

Marking Information (Note 5)



P1 = Product Type Marking Code

Note: 5. Package is non-polarized. Parts may be on reel in orientation illustrated, 180° rotated, or mixed (both ways).

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Drain-Source Voltage	V_{DSS}	-20	V	
Gate-Source Voltage	V_{GSS}	± 8	V	
Continuous Drain Current (Note 6) $V_{GS} = -4.5\text{V}$	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	-200 -150	mA
Continuous Drain Current (Note 6) $V_{GS} = -2.5\text{V}$	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_D	-170 -130	mA
Pulsed Drain Current	$T_P = 10\mu\text{s}$	I_{DM}	-600	mA

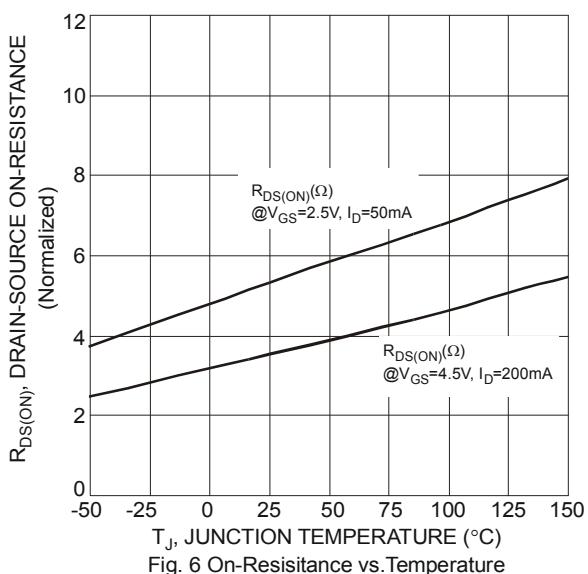
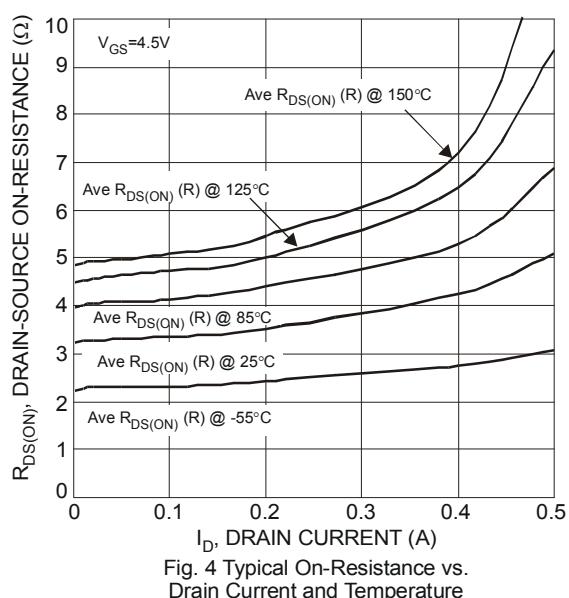
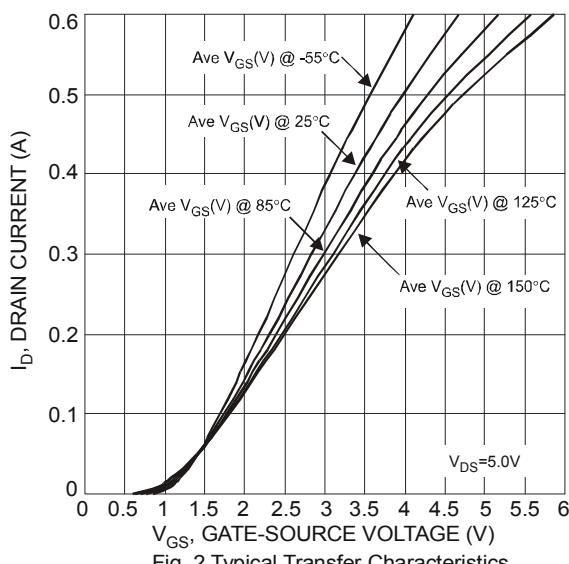
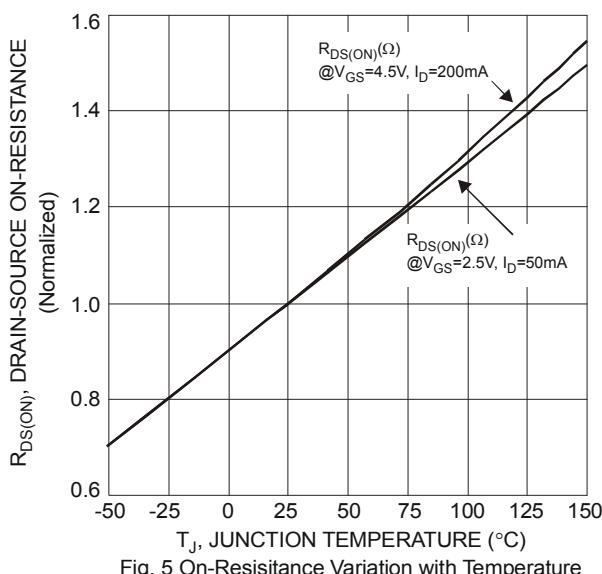
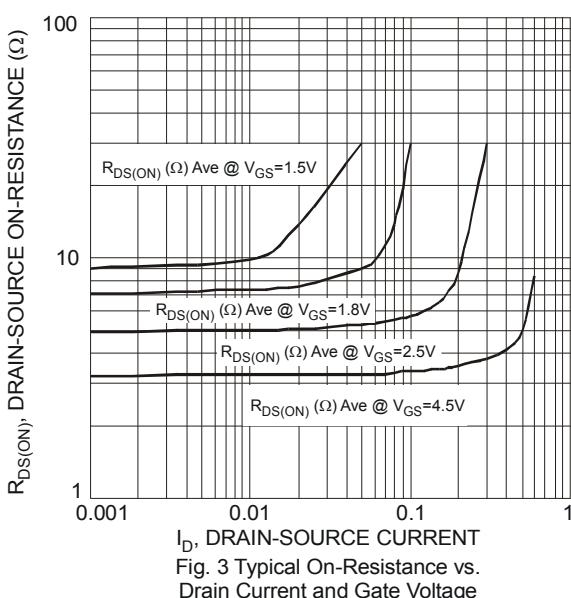
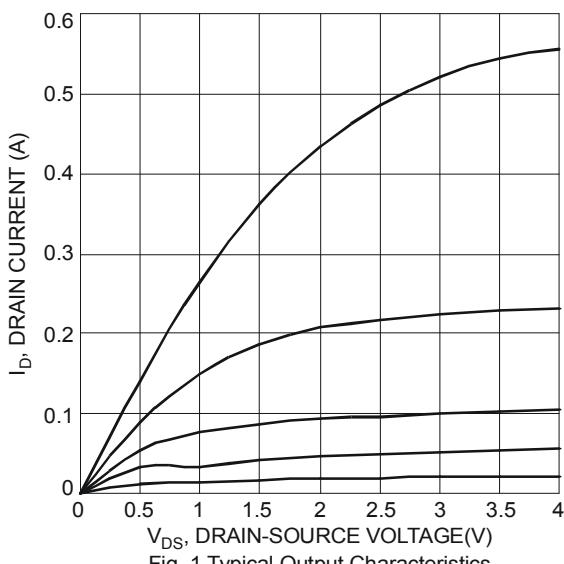
Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 6)	P_D	330	mW
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	377.16	°C/W
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV_{DSS}	-20	—	—	V	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-100 -50	nA nA	$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$ $V_{DS} = -5.0\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100 ±1	nA μA	$V_{GS} = \pm 5.0\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = \pm 8.0\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(\text{th})}$	-0.45	—	-1.15	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	—	—	5.5	Ω	$V_{GS} = -4.5\text{V}, I_D = -100\text{mA}$
		—	—	7.5		$V_{GS} = -2.5\text{V}, I_D = -50\text{mA}$
		—	—	11.5		$V_{GS} = -1.8\text{V}, I_D = -20\text{mA}$
		—	—	17.5		$V_{GS} = -1.5\text{V}, I_D = -10\text{mA}$
		—	20	—		$V_{GS} = -1.2\text{V}, I_D = -1\text{mA}$
		—	—	—		—
Forward Transfer Admittance	$ Y_{fs} $	150	200	—	mS	$V_{DS} = -10\text{V}, I_D = -0.2\text{A}$
Diode Forward Voltage (Note 7)	V_{SD}	-0.5	—	-1.2	V	$V_{GS} = 0\text{V}, I_S = -115\text{mA}$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C_{iss}	—	13.72	27.44	pF	$V_{DS} = -15\text{V}, V_{GS} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	4.01	8.02	pF	
Reverse Transfer Capacitance	C_{rss}	—	2.34	4.68	pF	
SWITCHING CHARACTERISTICS (Note 8)						
Turn-On Delay Time	$t_{d(\text{on})}$	—	7.7	—	ns	$V_{GS} = -4.5\text{V}, V_{DD} = -15\text{V}$ $I_D = -180\text{mA}, R_G = 2.0\Omega$
Rise Time	t_r	—	19.3	—		
Turn-Off Delay Time	$t_{d(\text{off})}$	—	25.9	—		
Fall Time	t_f	—	31.5	—		

Notes: 6. Device mounted on 1"x1" FR-4 substrate PC board, with minimum recommended pad layout, single sided.
 7. Short duration pulse test used to minimize self-heating effect.
 8. Guaranteed by design. Not subject to production testing.



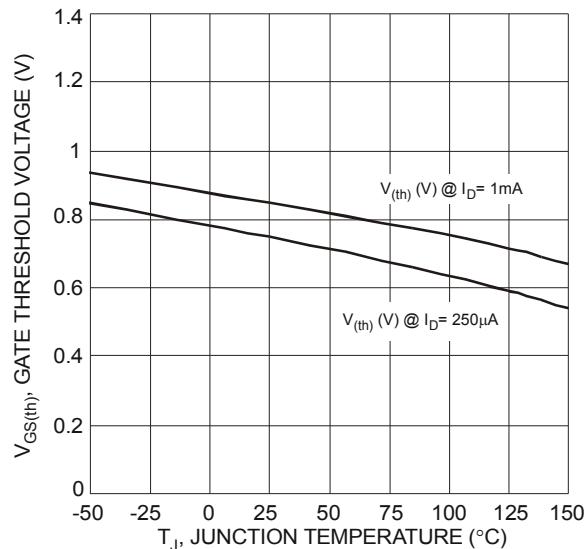


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

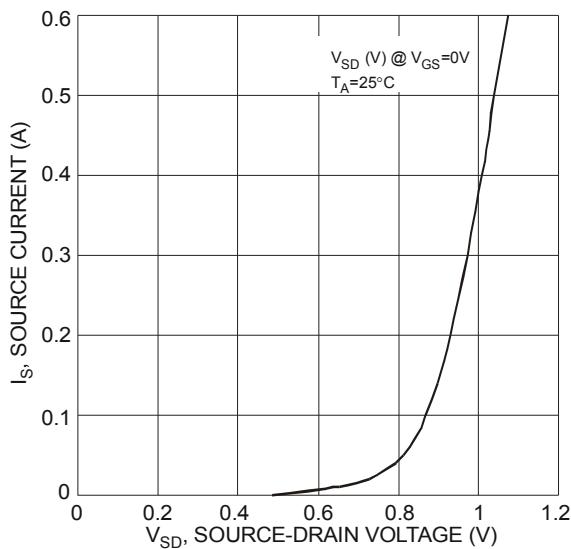


Fig. 8 Diode Forward Voltage vs. Current

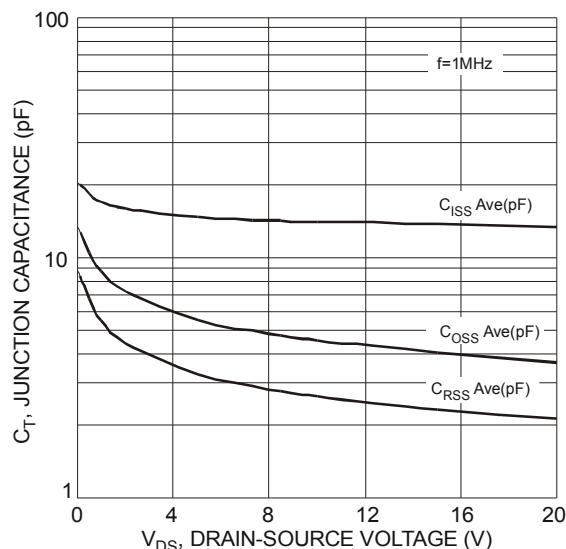


Fig. 9 Typical Junction Capacitance

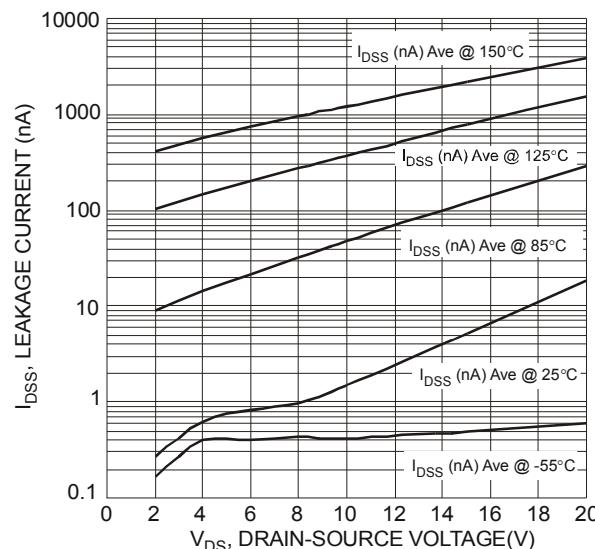


Fig. 10 Typical Drain-Source Leakage Current vs. Voltage

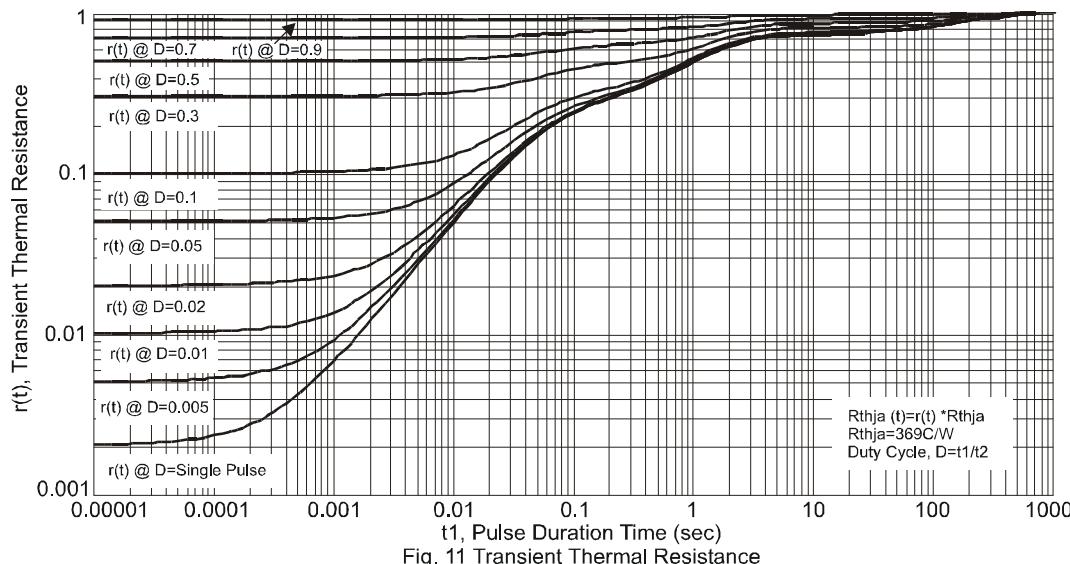


Fig. 11 Transient Thermal Resistance

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